

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/589,177	YAN ET AL.	
Examiner		Art Unit		Page 1 of 1
SYED ZIA		2431		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0147519 A1	08-2003	Jain et al.	379/211.02
*	B	US-2004/0105542 A1	06-2004	Takase et al.	380/044
*	C	US-6,981,263 B1	12-2005	Zhang et al.	719/310
*	D	US-7,349,412 B1	03-2008	Jones et al.	370/401
*	E	US-7,506,370 B2	03-2009	Aggarwal, Sudhir	726/14
*	F	US-7,590,843 B1	09-2009	Khalil et al.	713/171
*	G	US-7,599,352 B2	10-2009	Ruckstuhl, Hanspeter	370/352
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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